



comprises receiving input values for a process and measurement joint probability density function, a lower specification limit, an upper specification limit, a lower inspection limit, and an upper inspection limit.

[c8] 8.The method according to claim 1, wherein the step of determining the probability of each outcome comprises summing a joint probability density of the measurement variation and the product characteristic variation in each region.

[c9] 9.The method according to claim 8, wherein the probability density functions of the measurement variation and the product characteristic variation are normal distributions.

[c10] 10.The method according to claim 1, wherein the step of associating costs to various outcomes comprises associating unit costs to events of product inspection (CI), product scrapping or rework (CR), escaping defect (CE), and unnecessary rework (CR).

[c11] 11.The method according to claim 10, wherein the step of dividing the inspection plane into a plurality of regions comprises dividing the inspection plane into the following regions – product within its specification limit is accepted with probability p1, product outside its specification limit is rejection with probability p2, product within its specification limit is rejected with probability p3, and product outside its specification limit is accepted with probability p4.

[c12] 12.The method according to claim 11, wherein the step of computing overall costs comprises calculating unit costs for the events as follows – product inspection ( $1 \cdot CI$ ), product scrap or rework  $((p2 + p3) \cdot CR)$ , escaping defect  $(p4 \cdot CE)$ , and unnecessary rework  $(p3 \cdot CR)$ .

[c13] 13.The method according to claim 1, further comprising performing a second inspection on all products rejected in a first inspection.

[c14] 14.The method according to claim 13, wherein the second inspection comprises altering the measurement variations from the first inspection.



and the determined probability of each outcome based on the regions of the inspection plane.